

# IRL620SPbF

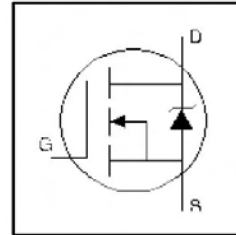
## HEXFET<sup>®</sup> Power MOSFET

- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Logic-Level Gate Drive
- R<sub>DS(on)</sub> Specified at V<sub>GS</sub>=4V & 5V
- Fast Switching
- Lead-Free

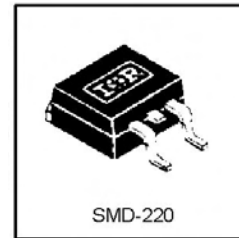
### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface-mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface-mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface-mount application.



V<sub>DSS</sub> = 200V  
R<sub>DS(on)</sub> = 0.80Ω  
I<sub>D</sub> = 5.2A



## Absolute Maximum Ratings

|   | Parameter   | Max.                  | Units |
|---|---|-----------------------|-------|
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 5.0 V | 5.2                   | A     |
| I <sub>D</sub> @ T <sub>C</sub> = 100°C | Continuous Drain Current, V <sub>GS</sub> @ 5.0 V | 3.3                   |       |
| I <sub>DM</sub>                         | Pulsed Drain Current Ⓞ                            | 21                    |       |
| P <sub>D</sub> @ T <sub>C</sub> = 25°C  | Power Dissipation                                 | 50                    | W     |
| P <sub>D</sub> @ T <sub>A</sub> = 25°C  | Power Dissipation (PCB Mount)**                   | 3.1                   |       |
|   | Linear Derating Factor                            | 0.40                  | W/°C  |
|   | Linear Derating Factor (PCB Mount)**              | 0.025                 |       |
| V <sub>GS</sub>                         | Gate-to-Source Voltage                            | ±10                   | V     |
| E <sub>AS</sub>                         | Single Pulse Avalanche Energy Ⓞ                   | 125                   | mJ    |
| I <sub>AR</sub>                         | Avalanche Current Ⓞ                               | 5.2                   | A     |
| E <sub>AR</sub>                         | Repetitive Avalanche Energy Ⓞ                     | 5.0                   | mJ    |
| dv/dt                                   | Peak Diode Recovery dv/dt Ⓞ                       | 5.0                   | V/ns  |
| T <sub>J</sub> , T <sub>STG</sub>       | Junction and Storage Temperature Range            | -55 to + 150          | °C    |
|   | Soldering Temperature, for 10 seconds             | 300 (1.6mm from case) |       |

## Thermal Resistance

|                  | Parameter                         | Min. | Typ. | Max. | Units |
|------------------|-----------------------------------|------|------|------|-------|
| R <sub>θJC</sub> | Junction-to-Case                  | —    | —    | 2.5  | °C/W  |
| R <sub>θJA</sub> | Junction-to-Ambient (PCB Mount)** | —    | —    | 40   |       |
| R <sub>θJA</sub> | Junction-to-Ambient               | —    | —    | 62   |       |

\*\* When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques, refer to Application Note AN-994.

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## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ. | Max. | Units    | Conditions  |
|---------------------------------|--------------------------------------|------|------|------|----------|---|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 200  | —    | —    | V        | $V_{GS} = 0V, I_D = 250\mu A$                         |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.27 | —    | V/°C     | Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$  |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.80 | $\Omega$ | $V_{GS} = 10.0V, I_D = 3.1A$ ①                        |
|                                 |                                      | —    | —    | 1.0  |          | $V_{GS} = 4.0V, I_D = 2.6A$ ②                         |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 1.0  | —    | 2.0  | V        | $V_{DS} = V_{GS}, I_D = 250\mu A$                     |
| $g_{fs}$                        | Forward Transconductance             | 1.2  | —    | —    | S        | $V_{DS} = 50V, I_D = 3.1A$                            |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25   | $\mu A$  | $V_{DS} = 200V, V_{GS} = 0V$                          |
|                                 |                                      | —    | —    | 250  |          | $V_{DS} = 320V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA       | $V_{GS} = 10V$  |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |          | $V_{GS} = -10V$                                       |
| $Q_g$                           | Total Gate Charge                    | —    | —    | 16   | nC       | $I_D = 5.2A$  |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —    | 2.9  |          | $V_{DS} = 160V$                                       |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —    | 9.6  |          | $V_{GS} = 5.0V$ , See Fig. 6 and 13 ③                 |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 4.2  | —    |          | $V_{DD} = 100V$                                       |
| $t_r$                           | Rise Time                            | —    | 31   | —    | ns       | $I_D = 5.2A$  |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 18   | —    |          | $R_G = 9.0\Omega$                                     |
| $t_f$                           | Fall Time                            | —    | 17   | —    |          | $R_D = 20\Omega$ , See Fig. 10 ④                      |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5  | —    | nH       | Between lead, 6mm (0.25in.)                           |
| $L_S$                           | Internal Source Inductance           | —    | 7.5  | —    |          | from package and center of die contact                |
| $C_{iss}$                       | Input Capacitance                    | —    | 360  | —    | pF       | $V_{GS} = 0V$   |
| $C_{oss}$                       | Output Capacitance                   | —    | 91   | —    |          | $V_{DS} = 25V$  |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 27   | —    |          | $f = 1.0\text{MHz}$ , See Fig. 5                      |



## Source-Drain Ratings and Characteristics

|          | Parameter                              | Min.  | Typ. | Max. | Units   | Conditions   |
|----------|--|---|------|------|---------|--|
| $I_S$    | Continuous Source Current (Body Diode) | —   | —    | 5.2  | A       | MOSFET symbol showing the integral reverse p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —   | —    | 21   |         |  |
| $V_{SD}$ | Diode Forward Voltage                  | —   | —    | 1.8  | V       | $T_J = 25^\circ\text{C}$ , $I_S = 5.2A$ , $V_{GS} = 0V$ ②      |
| $t_{rr}$ | Reverse Recovery Time                  | —   | 180  | 270  | ns      | $T_J = 25^\circ\text{C}$ , $I_F = 5.2A$                        |
| $Q_{rr}$ | Reverse Recovery Charge                | —   | 1.1  | 1.7  | $\mu C$ | $di/dt = 100A/\mu s$ ③   |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |         |  |

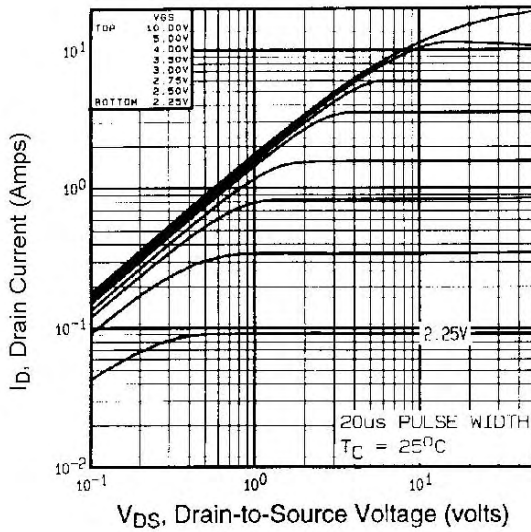
### Notes:

① Repetitive rating: pulse width limited by max. junction temperature. ( See fig. 11 )

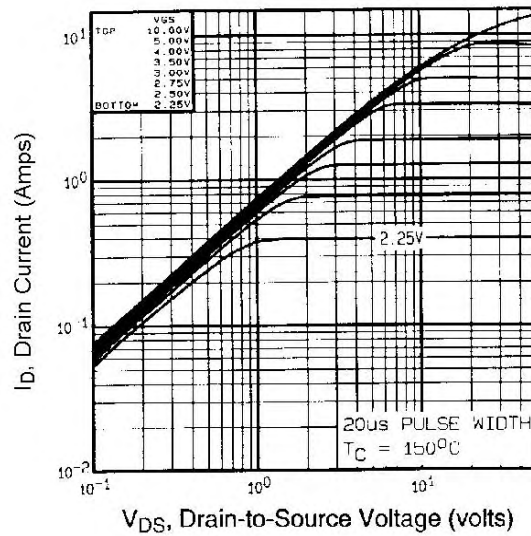
②  $I_{SD} \leq 5.2A$ ,  $di/dt \leq 95A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$

③  $V_{DD} = 50V$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 6.9\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 5.2A$ . (See Figure 12)

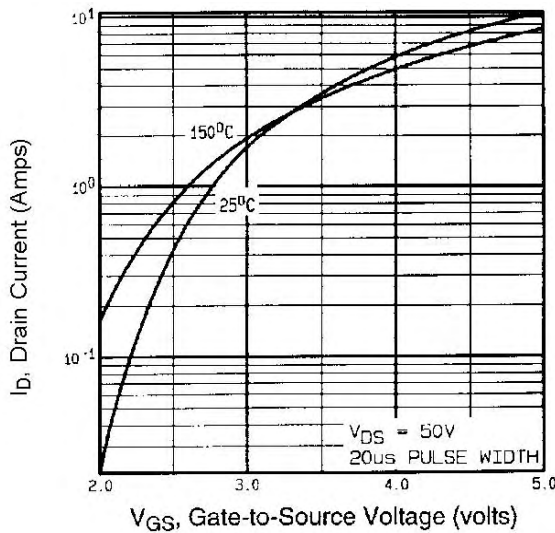
④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .



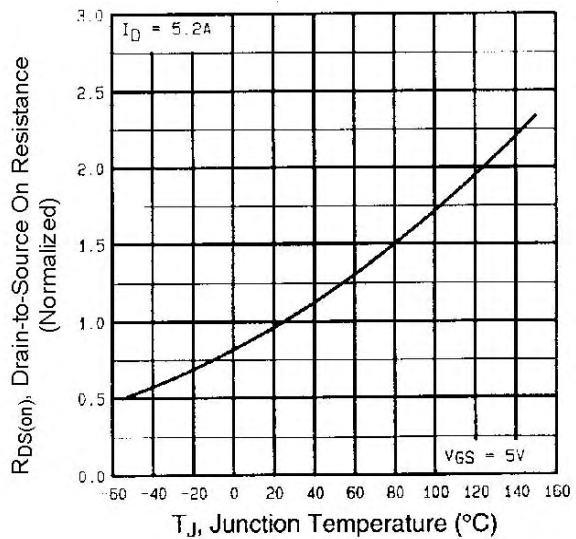
**Fig 1.** Typical Output Characteristics,  
 $T_C = 25^\circ\text{C}$



**Fig 2.** Typical Output Characteristics,  
 $T_C = 150^\circ\text{C}$

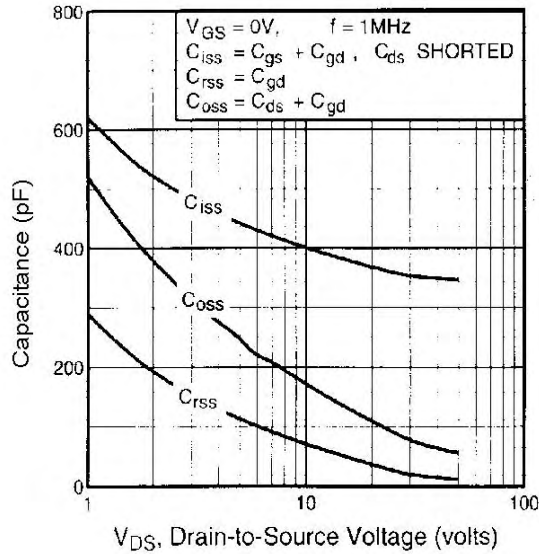


**Fig 3.** Typical Transfer Characteristics

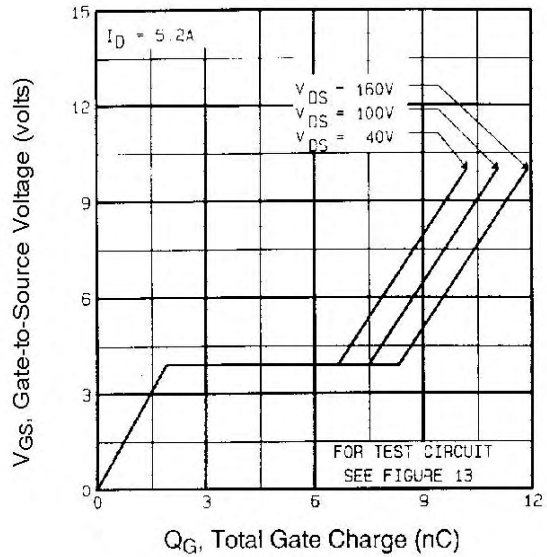


**Fig 4.** Normalized On-Resistance  
 Vs. Temperature

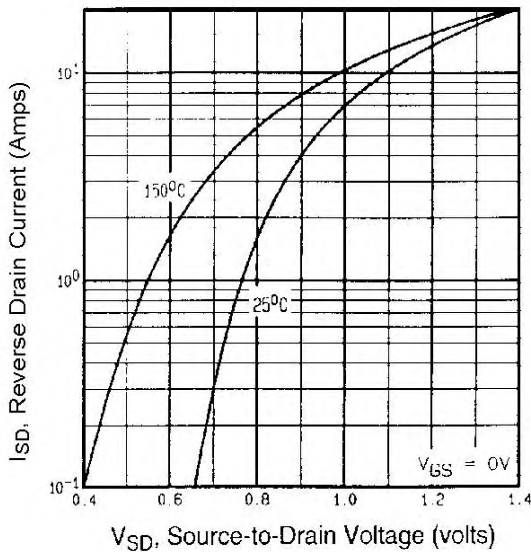
# IRL620SPbF



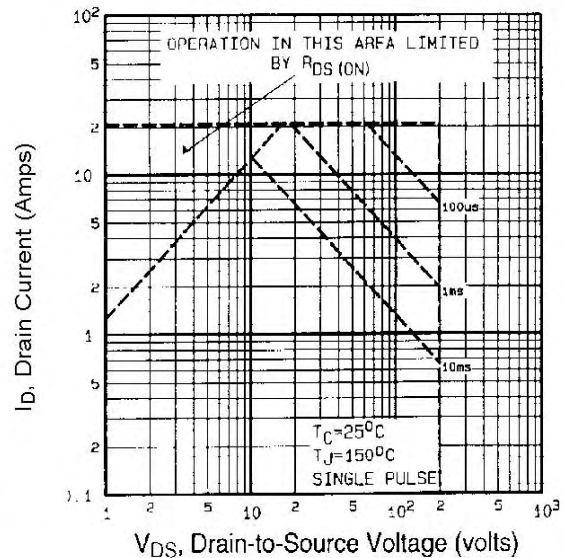
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



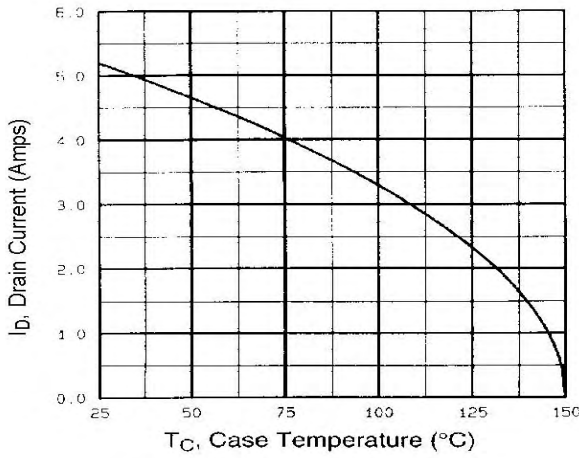
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



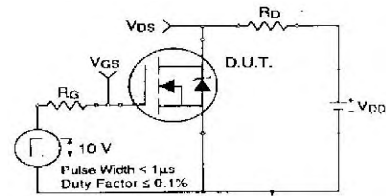
**Fig 7.** Typical Source-Drain Diode Forward Voltage



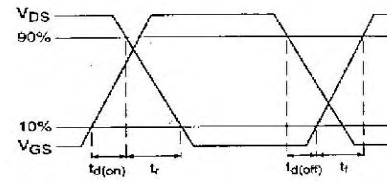
**Fig 8.** Maximum Safe Operating Area



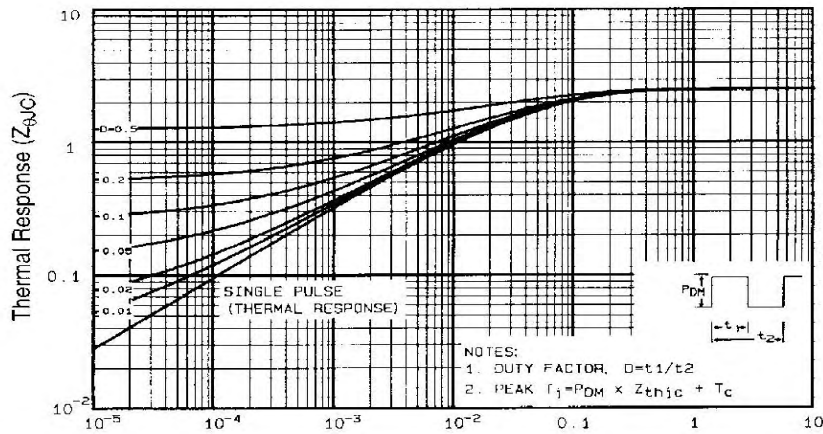
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit

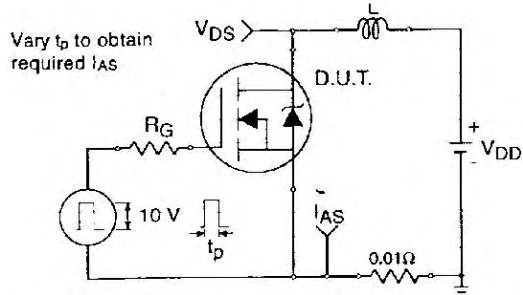


**Fig 10b.** Switching Time Waveforms

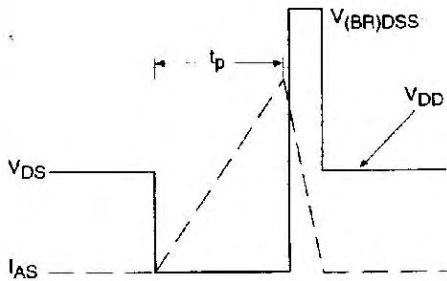


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

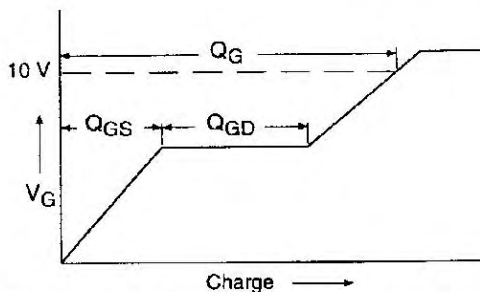
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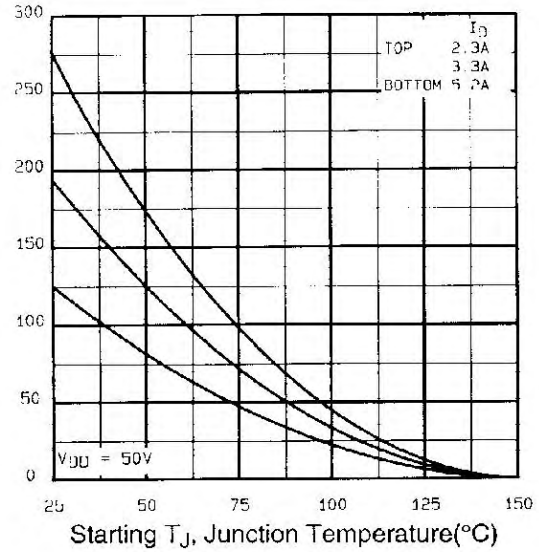
**Fig 12a.** Unclamped Inductive Test Circuit



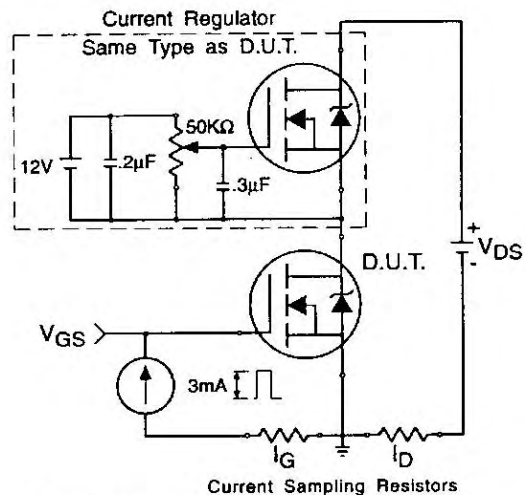
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 13a.** Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

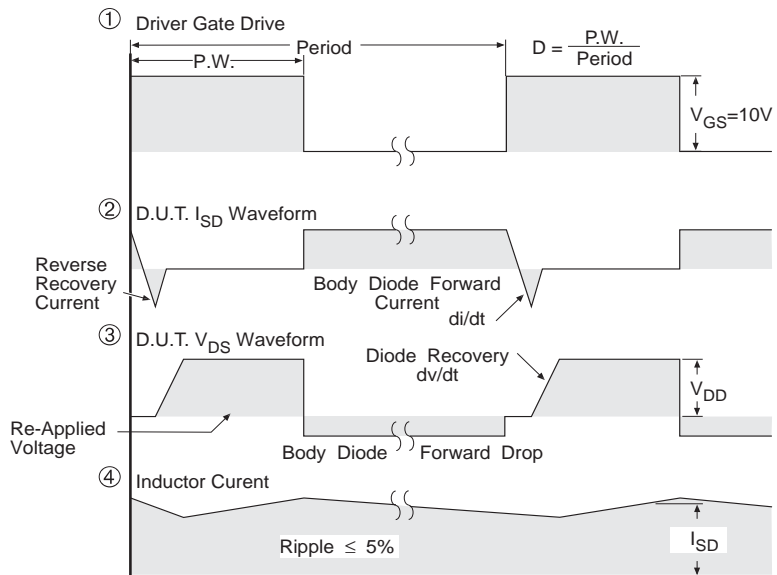


**Fig 13b.** Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit



- \* Reverse Polarity for P-Channel
- \*\* Use P-Channel Driver for P-Channel Measurements



\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

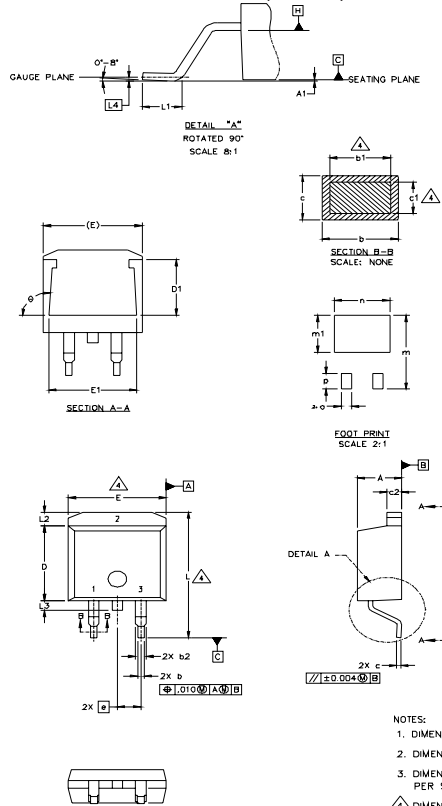
**Fig 14** For N Channel HEXFETS

# IRL620SPbF



## D<sup>2</sup>Pak Package Outline

Dimensions are shown in millimeters (inches)



| SYMBOL | DIMENSIONS  |       |          |      | NOTES |
|--------|-------------|-------|----------|------|-------|
|        | MILLIMETERS |       | INCHES   |      |       |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |
| A      | 4.06        | 4.83  | .160     | .190 | 4     |
| A1     |             | 0.127 |          | .005 |       |
| b      | 0.51        | 0.99  | .020     | .039 |       |
| b1     | 0.51        | 0.89  | .020     | .035 |       |
| b2     | 1.14        | 1.40  | .045     | .055 | 4     |
| c      | 0.43        | 0.63  | .017     | .025 |       |
| c1     | 0.38        | 0.74  | .015     | .029 | 3     |
| c2     | 1.14        | 1.40  | .045     | .055 |       |
| D      | 8.51        | 9.65  | .335     | .380 | 3     |
| D1     | 5.33        |       | .210     |      |       |
| E      | 9.65        | 10.67 | .380     | .420 | 3     |
| E1     | 6.22        |       | .245     |      |       |
| e      | 2.54 BSC    |       | .100 BSC |      |       |
| L      | 14.61       | 15.88 | .575     | .625 |       |
| L1     | 1.78        | 2.79  | .070     | .110 |       |
| L2     |             | 1.65  |          | .065 |       |
| L3     | 1.27        | 1.78  | .050     | .070 |       |
| L4     | 0.25 BSC    |       | .010 BSC |      |       |
| m      | 17.78       |       | .700     |      |       |
| m1     | 8.89        |       | .350     |      |       |
| n      | 11.43       |       | .450     |      |       |
| o      | 2.08        |       | .082     |      |       |
| p      | 3.81        |       | .150     |      |       |
| θ      | 90°         | 93°   | 90°      | 93°  |       |

### LEAD ASSIGNMENTS

| HEXFET     | IGBTs, CoPACK | DIODES      |
|------------|---------------|-------------|
| 1.- GATE   | 1.- GATE      | 1.- ANODE * |
| 2.- DRAIN  | 2.- COLLECTOR | 2.- CATHODE |
| 3.- SOURCE | 3.- EMITTER   | 3.- ANODE   |

\* PART DEPENDENT.

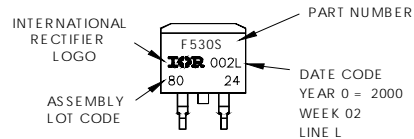
### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- △ DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
- CONTROLLING DIMENSION: INCH.

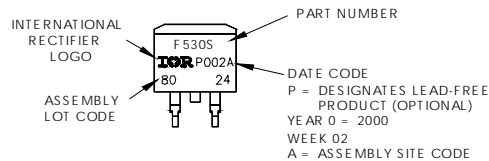
## D<sup>2</sup>Pak Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH LOT CODE 8024 ASSEMBLED ON WW 02, 2000 IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position indicates "Lead-Free"



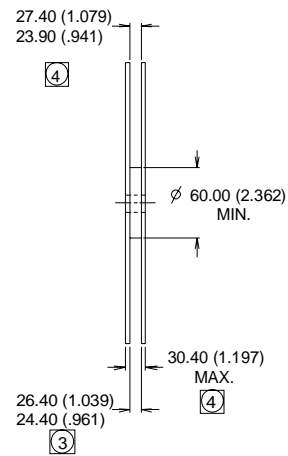
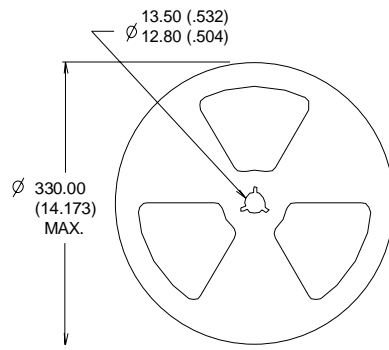
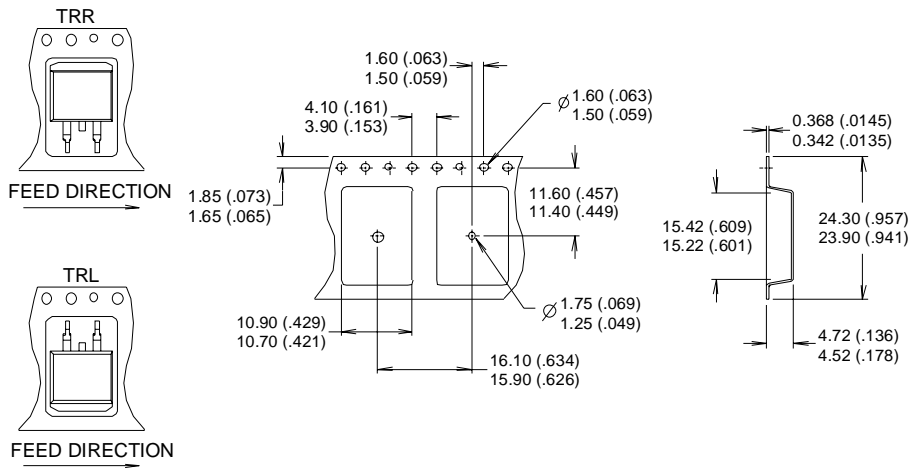
OR





## D<sup>2</sup>Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES:
1. CONFORMS TO EIA-418.
  2. CONTROLLING DIMENSION: MILLIMETER.
  - ③ DIMENSION MEASURED @ HUB.
  - ④ INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Data and specifications subject to change without notice.



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